Product Preview

Q0PACK Module

The NXH80T120L2Q0S2G is a power module containing a T-type neutral point clamped (NPC) three level inverter consisting of two 65 A/1200 V half-bridge IGBTs with 75 A/1200 V half-bridge diodes and two 60 A/600 V NPC IGBTs, with two 50 A/600 V NPC diodes. The module also contains an on-board thermistor.

Features

- T-type NPC Module with 65 A/1200 V and 60 A/600 V IGBTs
- HB IGBT Specifications: $V_{CE(SAT)} = 2.05 \text{ V}$, $E_{SW} = 1650 \mu\text{J}$
- NPC IGBT Specifications: $V_{CE(SAT)} = 1.40 \text{ V}$, $E_{SW} = 560 \mu\text{J}$
- Compact 65.9 mm x 32.5 mm x 12 mm Package
- Solder Pins
- Thermistor

Typical Applications

- Solar Inverter
- Uninterruptable Power Supplies

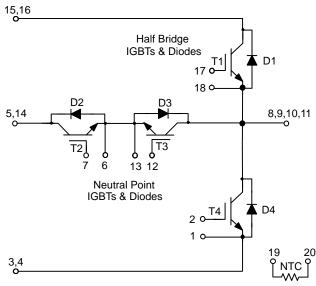


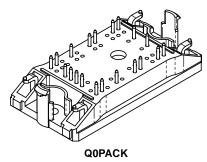
Figure 1. Schematic Diagram

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CASE 180AB



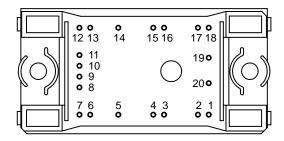
NXH80T120L2Q0S2G = Specific Device Code YYWW = Year and Work Week Code

A = Assembly Site Code

T = Test Site Code

G = Pb-free Package

PIN ASSIGNMENTS



ORDERING INFORMATION

See detailed ordering and shipping information in the dimensions section on page 15 of this data sheet.

Table 1. MAXIMUM RATINGS

Rating	Symbol	Value	Unit
HALF BRIDGE IGBT			
Collector–Emitter Voltage	V _{CES}	1200	V
Gate-Emitter Voltage	V _{GE}	±20	V
Continuous Collector Current @ T _C = 80°C (T _J = 175°C)	Ic	67	А
Pulsed Collector Current (T _J = 175°C)	I _{Cpulse}	201	А
Maximum Power Dissipation (T _J = 175°C)	P _{tot}	158	W
Short Circuit Withstand Time @ V_{GE} = 15 V, V_{CE} = 600 V, $T_{J} \le 150^{\circ}C$	T _{sc}	5	μs
Minimum Operating Junction Temperature	T _{JMIN}	-40	°C
Maximum Operating Junction Temperature	T _{JMAX}	150	°C
NEUTRAL POINT IGBT			
Collector–Emitter Voltage	V _{CES}	600	V
Gate-Emitter Voltage	V _{GE}	±20	V
Continuous Collector Current @ T _C = 80°C (T _J = 175°C)	I _C	49	А
Pulsed Collector Current (T _J = 175°C)	I _{Cpulse}	147	А
Maximum Power Dissipation (T _J = 175°C)	P _{tot}	86	W
Short Circuit Withstand Time @ V_{GE} = 15 V, V_{CE} = 400 V, $T_{J} \le 150^{\circ}C$	T _{sc}	5	μs
Minimum Operating Junction Temperature	T _{JMIN}	-40	°C
Maximum Operating Junction Temperature	T _{JMAX}	150	°C
HALF BRIDGE DIODE			
Peak Repetitive Reverse Voltage	V_{RRM}	1200	V
Continuous Forward Current @ T _C = 80°C (T _J = 175°C)	I _F	28	А
Repetitive Peak Forward Current (T _J = 175°C)	I _{FRM}	84	А
Maximum Power Dissipation (T _J = 175°C)	P _{tot}	73	W
Minimum Operating Junction Temperature	T _{JMIN}	-40	°C
Maximum Operating Junction Temperature	T _{JMAX}	150	°C
NEUTRAL POINT DIODE			
Peak Repetitive Reverse Voltage	V_{RRM}	600	V
Continuous Forward Current @ T _C = 80°C (T _J = 175°C)	l _F	33	А
Repetitive Peak Forward Current (T _J = 175°C)	I _{FRM}	99	А
Maximum Power Dissipation (T _J = 175°C)	P _{tot}	63	W
Minimum Operating Junction Temperature	T _{JMIN}	-40	°C
Maximum Operating Junction Temperature	T _{JMAX}	150	°C
THERMAL PROPERTIES			
Storage Temperature range	T _{stg}	-40 to 150	°C
INSULATION PROPERTIES			
Isolation test voltage, t = 1 sec, 60 Hz	V _{is}	3000	V _{RMS}
Creepage distance		12.7	mm

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

Table 2. RECOMMENDED OPERATING RANGES

Rating	Symbol	Min	Max	Unit
Module Operating Junction Temperature	T _{.1}	-40	T _{.IMAX} – 25	°C

Functional operation above the stresses listed in the Recommended Operating Ranges is not implied. Extended exposure to stresses beyond the Recommended Operating Ranges limits may affect device reliability.

^{1.} Refer to ELECTRICAL CHĂRACTERISTICS, RECOMMENDED OPERATING RANGES and/or APPLICATION INFORMATION for Safe Operating parameters.

Table 3. ELECTRICAL CHARACTERISTICS $T_J = 25^{\circ}C$ unless otherwise noted

Parameter	Test Conditions	Symbol	Min	Тур	Max	Unit
HALF BRIDGE IGBT CHARACTERISTICS		•				
Collector–Emitter Cutoff Current	V _{GE} = 0 V, V _{CE} = 1200 V	I _{CES}	-	_	300	μΑ
Collector–Emitter Saturation Voltage	V _{GE} = 15 V, I _C = 80 A, T _J = 25°C	V _{CE(sat)}	_	2.05	2.85	V
	V _{GE} = 15 V, I _C = 80 A, T _J = 150°C	1 1	_	2.10	1	1
Gate-Emitter Threshold Voltage	$V_{GE} = V_{CE}$, $I_C = 1.5$ mA	V _{GE(TH)}	-	5.45	6.4	V
Gate Leakage Current	V _{GE} = 20 V, V _{CE} = 0 V	I _{GES}	-	_	300	nA
Turn-on Delay Time	T _J = 25°C	t _{d(on)}	-	61	-	ns
Rise Time	$V_{CE} = 350 \text{ V}, I_{C} = 60 \text{ A}$	t _r	-	28	-	1
Turn-off Delay Time	$V_{GE} = \pm 15V, R_{G} = 4.7 \Omega$	t _{d(off)}	-	205	-]
Fall Time	7	t _f	_	41	_	
Turn-on Switching Loss per Pulse	7	E _{on}	-	550	-	μJ
Turn off Switching Loss per Pulse	1	E _{off}	-	1100	-]
Turn-on Delay Time	T _J = 125°C	t _{d(on)}	-	58	-	ns
Rise Time	$V_{CE} = 350 \text{ V}, I_{C} = 60 \text{ A}$	t _r	-	30	-]
Turn-off Delay Time	$V_{GE} = \pm 15 \text{ V}, R_{G} = 4.7 \Omega$	t _{d(off)}	_	230	_	
Fall Time	1	t _f	-	63	-	1
Turn-on Switching Loss per Pulse	7	E _{on}	-	720	-	μJ
Turn off Switching Loss per Pulse	1	E _{off}	-	1700	-	1
Input Capacitance	V _{CE} = 20 V, V _{GE} = 0 V, f = 10 kHz	C _{ies}	-	19400	-	pF
Output Capacitance	7	C _{oes}	-	400	-	
Reverse Transfer Capacitance	1	C _{res}	-	340	-	1
Total Gate Charge	$V_{CE} = 600 \text{ V}, I_{C} = 80 \text{ A}, V_{GE} = \pm 15 \text{ V}$	Q_g	-	800	-	nC
Thermal Resistance – chip–to–heatsink	Thermal grease, Thickness = 76 μ m $\pm 2\%$, λ = 2.9 W/mK	R _{thJH}	-	0.60	ı	°C/W
NEUTRAL POINT DIODE CHARACTERIST	rics					
Diode Forward Voltage	I _F = 60 A, T _J = 25°C	V_{F}	-	1.7	2.2	V
	I _F = 60 A, T _J = 150°C	1 1	-	1.6	-	
Reverse Recovery Time	T _J = 25°C	t _{rr}	-	39	-	ns
Reverse Recovery Charge	$V_{CE} = 350 \text{ V, } I_{C} = 60 \text{ A}$	Q _{rr}	-	1.1	-	μС
Peak Reverse Recovery Current	$V_{GE} = \pm 15 \text{ V}, R_{G} = 4.7 \Omega$	I _{RRM}	-	48	-	Α
Peak Rate of Fall of Recovery Current	1	di/dt	-	3400	-	A/μs
Reverse Recovery Energy	7	E _{rr}	-	400	-	μJ
Reverse Recovery Time	T _J = 125°C	t _{rr}	-	78	-	ns
Reverse Recovery Charge	$V_{CE} = 350 \text{ V, } I_{C} = 60 \text{ A}$	Q _{rr}	-	2.0	-	μС
Peak Reverse Recovery Current	V_{GE} = ±15 V, R_G = 4.7 Ω	I _{RRM}	-	59	1	Α
Peak Rate of Fall of Recovery Current	7	di/dt	-	1600	1	A/μs
Reverse Recovery Energy	7	E _{rr}	-	550	-	μJ
Thermal Resistance – chip–to–heatsink	Thermal grease, Thickness = 76 μ m \pm 2%, λ = 2.9 W/mK	R _{thJH}	_	1.50	_	°C/W
NEUTRAL POINT IGBT CHARACTERISTIC	cs					
Collector-Emitter Cutoff Current	V _{GE} = 0 V, V _{CE} = 600 V	I _{CES}	_	_	200	μΑ
Collector–Emitter Saturation Voltage	V _{GE} = 15 V, I _C = 50 A, T _J = 25°C	V _{CE(sat)}	_	1.40	1.75	V
-	V _{GE} = 15 V, I _C = 50 A, T _J = 150°C	1	-	1.50	_	1
Gate-Emitter Threshold Voltage	$V_{GE} = V_{CE}, I_{C} = 1.2 \text{ mA}$	V _{GE(TH)}	-	5.45	6.4	V
Gate Leakage Current	V _{GE} = 20 V, V _{CE} = 0 V	I _{GES}	_	-	200	nA

Table 3. ELECTRICAL CHARACTERISTICS T_J = $25^{\circ}\mathsf{C}$ unless otherwise noted

Parameter	Test Conditions	Symbol	Min	Тур	Max	Unit
NEUTRAL POINT IGBT CHARACTERISTI	cs					
Turn-on Delay Time	T _J = 25°C	t _{d(on)}		30	-	ns
Rise Time	$V_{CE} = 350 \text{ V}, I_{C} = 60 \text{ A}$ $V_{GE} = \pm 15 \text{ V}, R_{G} = 4.7 \Omega$	t _r	_	19	_	1
Turn-off Delay Time	$V_{GE} = \pm 13 \text{ V}, \text{ KG} = 4.7 \text{ S2}$	t _{d(off)}	-	110	-	
Fall Time		t _f	_	23	_	
Turn-on Switching Loss per Pulse		E _{on}	_	800	-	μJ
Turn off Switching Loss per Pulse		E _{off}	_	480	_	
Turn-on Delay Time	T _J = 125°C	t _{d(on)}	_	32	-	ns
Rise Time	$V_{CE} = 350 \text{ V, } I_{C} = 60 \text{ A}$	t _r	_	18	_	
Turn-off Delay Time	$V_{GE} = \pm 15 \text{ V}, R_{G} = 4.7 \Omega$	t _{d(off)}		120	-	-
Fall Time	-	t _f	_	35	_	
Turn-on Switching Loss per Pulse	_	E _{on}		1100	_	μJ
Turn off Switching Loss per Pulse	_	E _{off}		880		· '
Input Capacitance	V _{CE} = 20 V, V _{GE} = 0 V, f = 10 kHz	C _{ies}	_	9400	_	pF
Output Capacitance	VCE = 20 V, VGE = 0 V, T = 10 KHZ	C _{oes}		280	_	ł ^{P'}
Reverse Transfer Capacitance	_	C _{res}		250	_	1
Total Gate Charge	$V_{CE} = 480 \text{ V}, I_{C} = 50 \text{ A}, V_{GE} = \pm 15 \text{ V}$	Q _g		395	_	nC
Thermal Resistance – chip–to–heatsink	Thermal grease,	R _{thJH}		1.10		°C/W
	Thickness = 76 μ m $\pm 2\%$, λ = 2.9 W/mK	· · · · · · · · · · · · · · · · · · · ·				0,11
HALF BRIDGE DIODE CHARACTERISTIC	S	_				
Diode Forward Voltage	I _F = 40 A, T _J = 25°C	V_{F}	-	2.11	2.90	V
	I _F = 40 A, T _J = 150°C		-	1.50	-	
Reverse recovery time	T _J = 25°C	t _{rr}	-	45	_	ns
Reverse recovery charge	$V_{CE} = 350 \text{ V}, I_{C} = 60 \text{ A}$ $V_{GE} = \pm 15 \text{ V}, R_{G} = 4.7 \Omega$	Q_{rr}	_	2.7	_	μC
Peak reverse recovery current	VGE = ±10 V, NG = 111 22	I _{RRM}	_	110	_	Α
Peak rate of fall of recovery current		di/dt	_	7100	_	A/μs
Reverse recovery energy		E _{rr}	_	1000	_	μJ
Reverse recovery time	T _J = 125°C	t _{rr}	-	185	_	ns
Reverse recovery charge	$V_{CE} = 350 \text{ V}, I_{C} = 60 \text{ A}$ $V_{GE} = \pm 15 \text{ V}, R_{G} = 4.7 \Omega$	Q_{rr}	_	6	_	μС
Peak reverse recovery current	VGE = ±13 V, NG = 4.7 ss	I_{RRM}	_	150	_	Α
Peak rate of fall of recovery current		di/dt	_	5900	_	A/μs
Reverse recovery energy		E_{rr}	-	1900	_	μJ
Thermal Resistance – chip-to-heatsink	Thermal grease, Thickness = 76 μ m $\pm 2\%$, λ = 2.9 W/mK	R _{thJH}	-	130	Í	°C/W
THERMISTOR CHARACTERISTICS						
Nominal resistance	T = 25°C	R ₂₅	-	22	-	kΩ
Nominal resistance	T = 100°C	R ₁₀₀	_	1486	_	Ω
Deviation of R25		ΔR/R	- 5	_	5	%
Power dissipation		P _D	-	200	-	mW
Power dissipation constant			-	2	-	mW/K
B-value	B(25/50), tolerance ±3%		_	3950	_	K
B-value	B(25/100), tolerance ±3%		_	3998	_	K

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

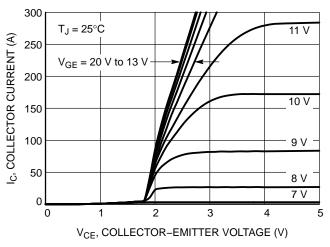


Figure 2. Typical Output Characteristics

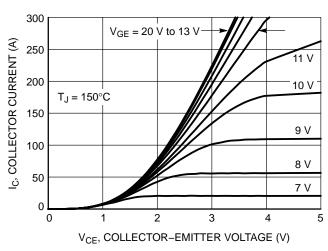


Figure 3. Typical Output Characteristics

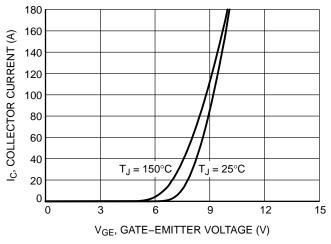


Figure 4. Typical Transfer Characteristics

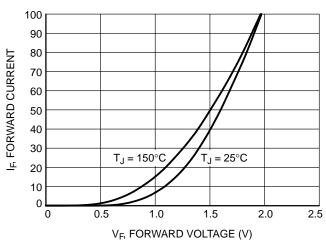


Figure 5. Diode Forward Characteristics

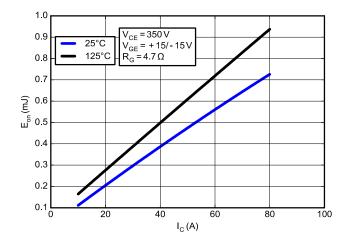


Figure 6. Typical Turn On Loss vs. IC

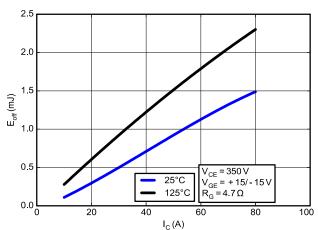
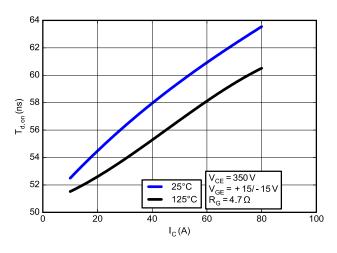


Figure 7. Typical Turn Off Loss vs. IC



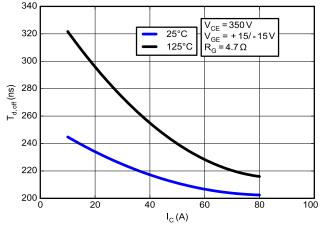
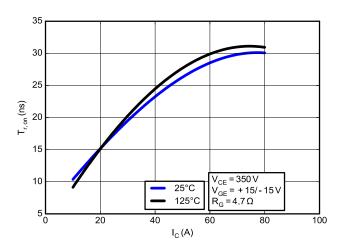


Figure 8. Typical On Switching Times vs. IC

Figure 9. Typical Off Switching Times vs. IC



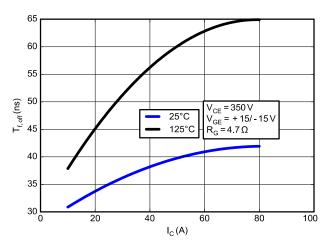
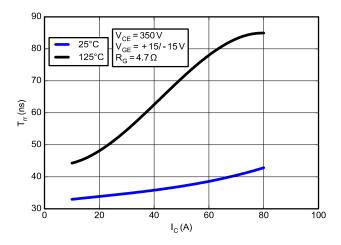


Figure 10. Typical On Rise Times vs. IC

Figure 11. Typical Off Fall Times vs. IC



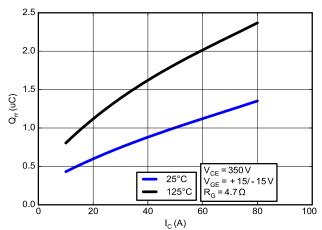
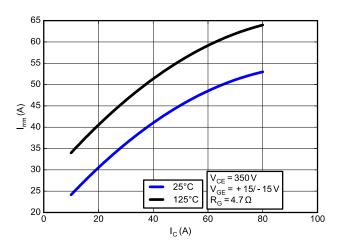


Figure 12. Typical Reverse Recovery Time vs.

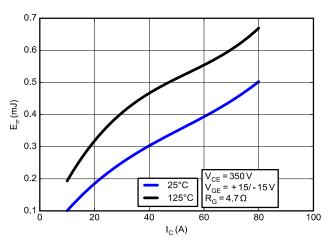
Figure 13. Typical Reverse Recovery Charge vs. IC



3500 3000 di/dt(A/µs) V_{CE} = 350 V V_{GE} = +15/-15 V 25°C 125°C $R_G^{\circ} = 4.7\Omega$ 2000 1500 1000 L 20 40 60 80 100 $I_{C}(A)$

Figure 14. Typical Reverse Recovery Peak Current vs. IC

Figure 15. Typical Diode Current Slope vs. IC



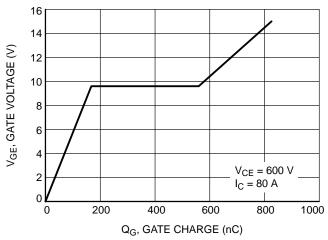


Figure 16. Typical Reverse Recovery Energy vs. IC

Figure 17. Gate Voltage vs. Gate Charge

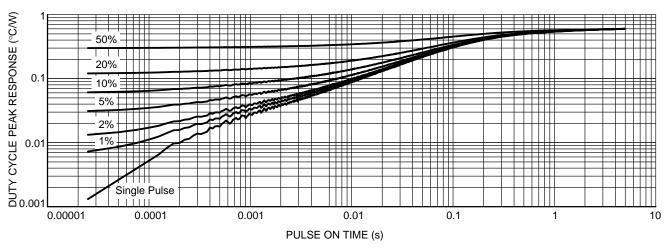


Figure 18. IGBT Transient Thermal Impedance

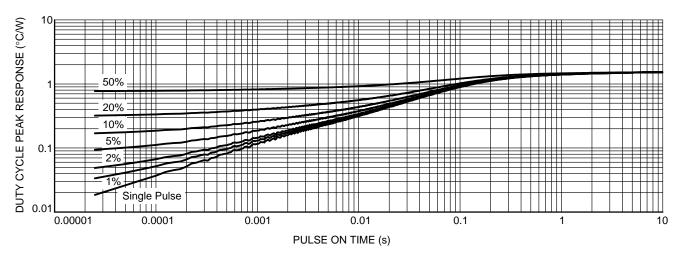


Figure 19. Diode Transient Thermal Impedance

TYPICAL CHARACTERISTICS - Neutral Point IGBT and Half Bridge Diode

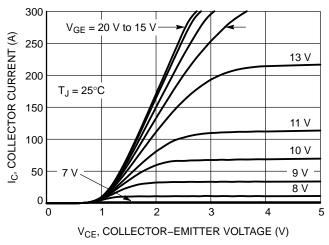


Figure 20. Typical Output Characteristics

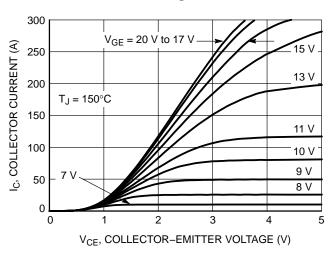


Figure 21. Typical Output Characteristics

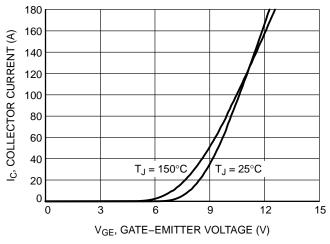


Figure 22. Typical Transfer Characteristics

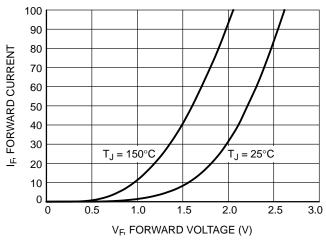


Figure 23. Diode Forward Characteristics

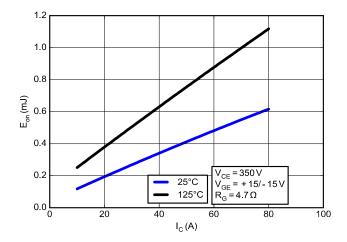


Figure 24. Typical Turn On Loss vs. IC

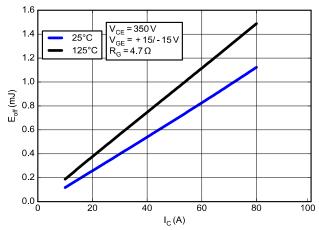
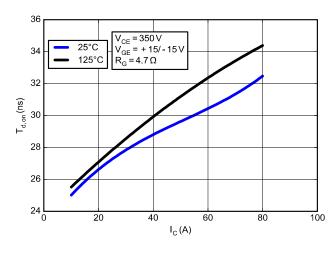


Figure 25. Typical Turn Off Loss vs. IC

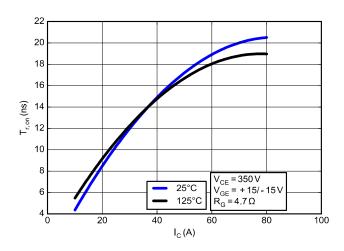
TYPICAL CHARACTERISTICS - Neutral Point IGBT and Half Bridge Diode



 $V_{CE} = 350 \, V$ 180 25°C $V_{GE} = +15/-15 V$ 125°C 170 $R_G = 4.7 \Omega$ 160 (su) 150 L 140 130 120 110 100 L 60 20 40 80 100 $I_C(A)$

Figure 26. Typical On Switching Times vs. IC

Figure 27. Typical Off Switching Times vs. IC



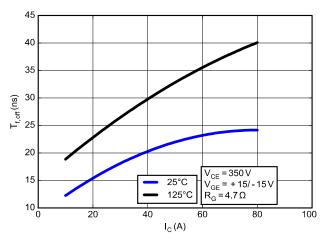
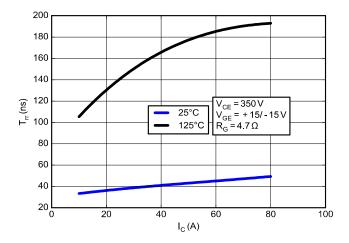


Figure 28. Typical On Rise Times vs. IC

Figure 29. Typical Off Fall Times vs. IC



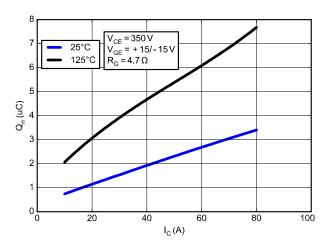
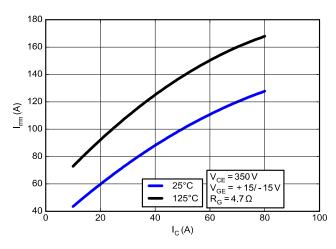


Figure 30. Typical Reverse Recovery Time vs.

Figure 31. Typical Reverse Recovery Charge vs. IC

TYPICAL CHARACTERISTICS - Neutral Point IGBT and Half Bridge Diode

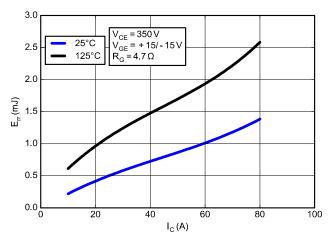
16



9000 8000 7000 di/dt(A/µs) 6000 5000 $V_{CE} = 350 \text{ V}$ 4000 $V_{GE} = +15/-15V$ $R_{G} = 4.7\Omega$ 25°C 125°C 3000 L 80 100 20 40 $I_{C}(A)$

Figure 32. Typical Reverse Recovery Peak Current vs. IC

Figure 33. Typical Diode Current Slope vs. IC



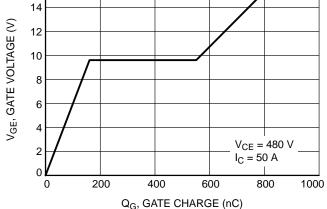


Figure 34. Typical Reverse Recovery Energy vs. IC

Figure 35. Gate Voltage vs. Gate Charge

TYPICAL CHARACTERISTICS - Neutral Point IGBT and Half Bridge Diode

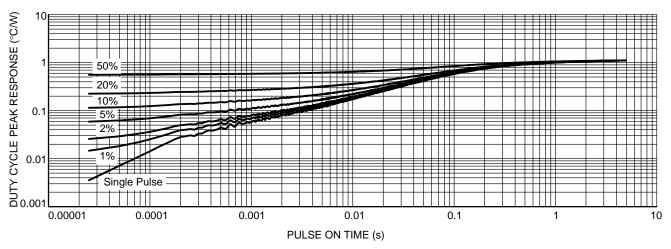


Figure 36. IGBT Transient Thermal Impedance

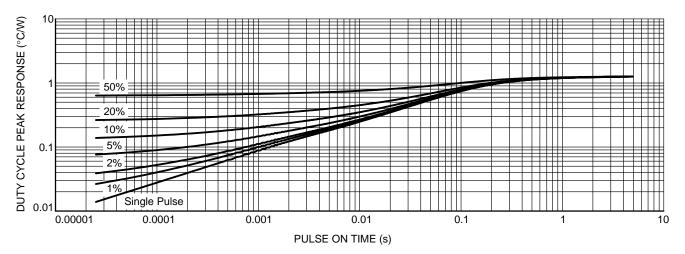


Figure 37. Diode Transient Thermal Impedance

TYPICAL CHARACTERISTICS – Thermistor

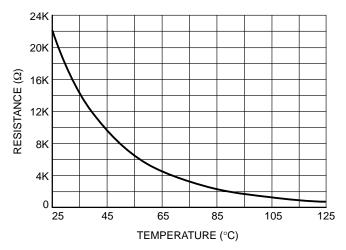
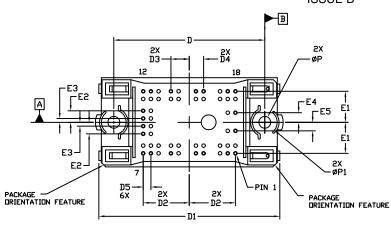


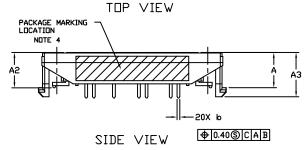
Figure 38. Thermistor Characteristics

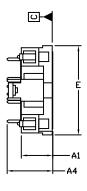
PACKAGE DIMENSIONS

PIM20, 55x32.5 / Q0PACK

CASE 180AB ISSUE B







END VIEW

NOTES:

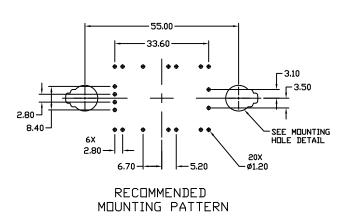
- 1. DIMENSIONING AND TOLERANCING PER. ASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- 3. DIMENSION & APPLIES TO THE PLATED TERMINALS AND ARE MEASURED BETWEEN 1.00 AND 3.00 FROM TERMINAL TIP.
- PACKAGE MARKING IS LOCATED AS SHOWN ON THE SIDE OPPOSITE THE PACKAGE ORIENTATION FEATURES.

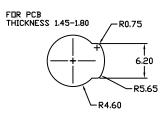
	MILLIMETERS		
DIM	MIN.	MAX.	
Α	13.10	14.10	
A1	10.75	11.75	
A2	12.20	13.20	
A3	15.45	16.45	
A4	16.40	REF	
b	0.95	1.05	
D	54.80	55.20	
D1	65.70	70.10	
D2	16.80 BSC		
D3	6.70 BSC		
D4	5.20 BSC		
D5	2.80	BSC	
E	32.00	33.00	
E1	11.30 BSC		
E2	4.20 BSC		
E3	1.40 BSC		
E4	3.50 BSC		
E5	3.10	BSC	
Р	4.10	4.50	
P1	8.50	9.50	

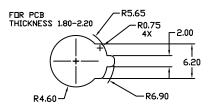
PACKAGE DIMENSIONS

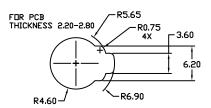
PIM20, 55x32.5 / Q0PACK CASE 180AB

ISSUE B









MOUNTING HOLE DETAIL

ORDERING INFORMATION

Orderable Part Number	Marking	Package	Shipping
NXH80T120L2Q0S2G Q0PACK	NXH80T120L2Q0S2G	Q0PACK – Case 180AB (Pb–Free and Halide–Free)	24 Units / Blister Tray

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